FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		WEBER, M.A. 1 PCT		SERIAL	serial no. 10/534,395			
LIST OF REFERENCES CITED BY APPLICANT POV 8 0 2007				APPLICANT: Mark A. WEBER						
(Use several sheets if necessary)				FILING DATE: May 10, 2005			GROUP: 2872			
U.S. PATENT DOCUMENTS										
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	AR	Tiziani, Hans J., and Hans-Martin Uhde, "Three-dimensional analysis by a microlens-array confocal arrangement," Applied Optics, (1994) Vol. 33, No. 4, pgs. 567-572.								
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EXAMINER				DATE CONSIDERED						
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										